

## Product Summary

$V_{(BR)DSS}$	$R_{DS(on)MAX}$	$I_D$
40V	6.8mΩ@10V	60A

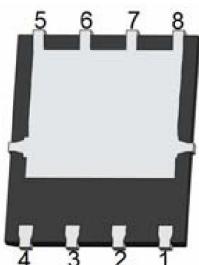
## Feature

- Split gate trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low  $R_{DS(ON)}$
- Suffix "-Q1" for AEC-Q101

## Application

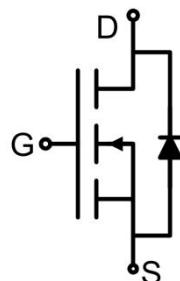
- DC-DC converter
- Power switching application
- Uninterruptible power supply

## Package

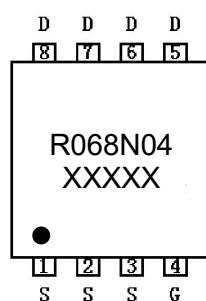


PDFN5\*6-8L

## Circuit diagram



## Marking



**Absolute maximum ratings (T<sub>A</sub>=25°C unless otherwise noted)**

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DS</sub>	40	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current(T <sub>C</sub> =25°C)	I <sub>D</sub>	60	A
Continuous Drain Current (T <sub>C</sub> =100°C)	I <sub>D</sub> (100°C)	42	A
Pulsed Drain Current <sup>1)</sup>	I <sub>DM</sub>	240	A
Power Dissipation(T <sub>C</sub> =25°C) <sup>3)</sup>	P <sub>D</sub>	75	W
Thermal Resistance,Junction-to-Ambient <sup>4)</sup>	R <sub>θJA</sub>	55	°C/W
Thermal Resistance,Junction-to-Case	R <sub>θJC</sub>	2	°C/W
Single pulse avalanche energy <sup>2)</sup>	E <sub>AS</sub>	84.5	mJ
Junction Temperature	T <sub>J</sub>	175	°C
Storage Temperature	T <sub>STG</sub>	-55 ~ +175	°C

**Electrical characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)**

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> =250μA	40			V
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> =40V, V <sub>GS</sub> = 0V			1	μA
		V <sub>DS</sub> =40V, V <sub>GS</sub> = 0V, T <sub>j</sub> =175°C			100	
Gate-body leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> = 0V			±100	nA
Gate threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	2.0	3.0	4.0	V
Drain-source on-resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =20A		5.2	6.8	mΩ
<b>Dynamic characteristics<sup>5)</sup></b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V, f =1MHz		965		pF
Output Capacitance	C <sub>oss</sub>			350		
Reverse Transfer Capacitance	C <sub>rss</sub>			11		
Gate resistance	R <sub>G</sub>	f =1.0MHz		2		Ω
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =20V, V <sub>GS</sub> =10V, I <sub>D</sub> =25A		12.5		nC
Gate-Source Charge	Q <sub>gs</sub>			4.6		
Gate-Drain Charge	Q <sub>gd</sub>			2.9		
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DD</sub> =20V, V <sub>GS</sub> =10V, I <sub>D</sub> =25A, R <sub>GEN</sub> =2.2Ω		9		nS
Turn-on rise time	t <sub>r</sub>			127		
Turn-off delay time	t <sub>d(off)</sub>			14		
Turn-off fall time	t <sub>f</sub>			5		
<b>Source-Drain Diode characteristics</b>						
Diode Forward Current	I <sub>S</sub>			60		A
Diode Forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =20A		1.2		V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =25A, di/dt =170A/μs		17.5		nS
Reverse Recovery Charge	Q <sub>rr</sub>			10		nC

Notes:

- 1) Repetitive rating; pulse width limited by max. junction temperature.
- 2) T<sub>J</sub>=25°C, V<sub>G</sub>=10V, R<sub>G</sub>=25Ω, L=1mH, IAS=13A.
- 3) P<sub>d</sub> is based on max. junction temperature, using junction-case thermal resistance.
- 4) The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25°C. The maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 5) Guaranteed by design, not subject to production testing.



### Typical Characteristics

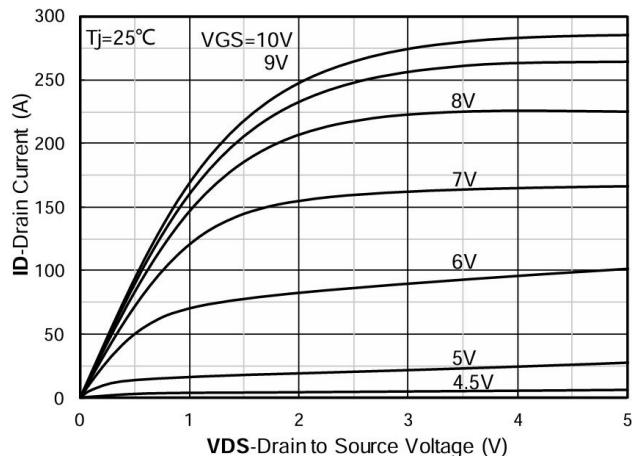


Figure 1. Output Characteristics

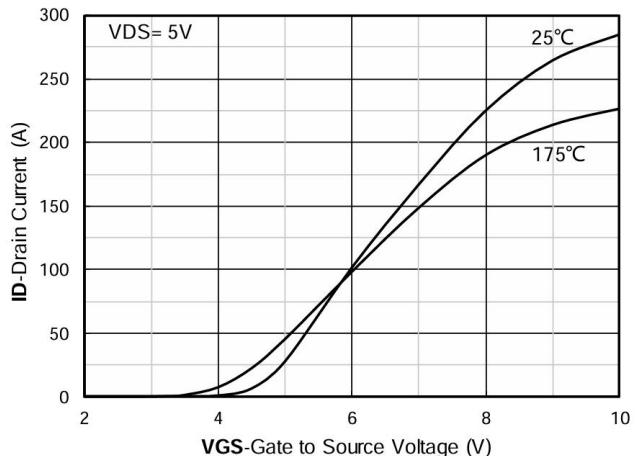


Figure 2. Transfer Characteristics

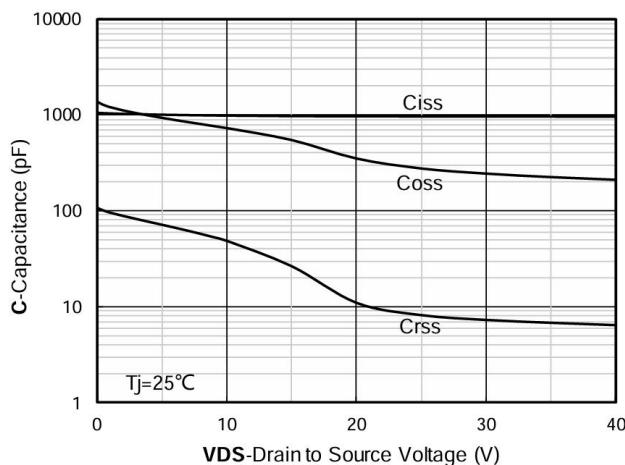


Figure 3. Capacitance Characteristics

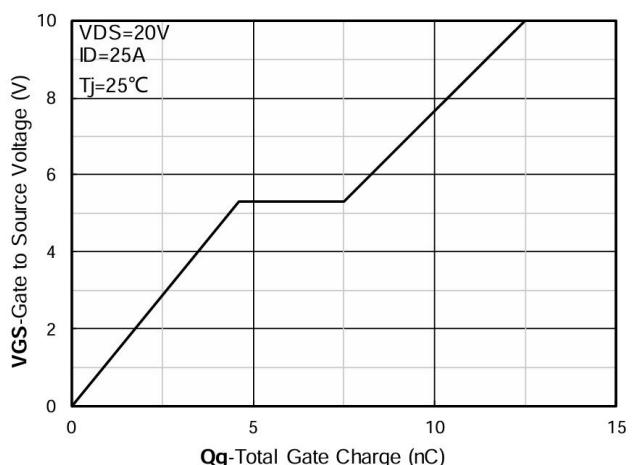


Figure 4. Gate Charge

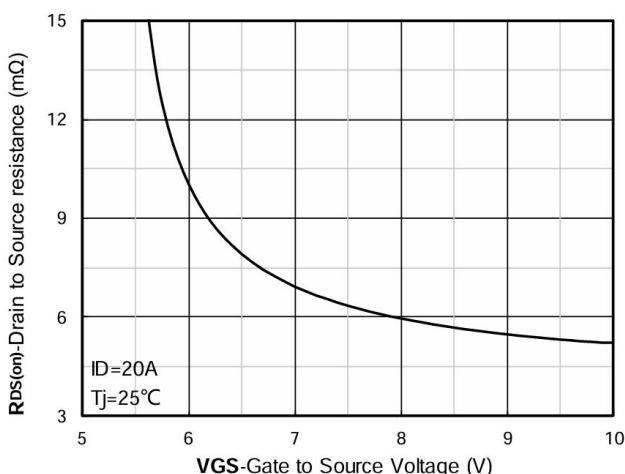


Figure 5. On-Resistance vs Gate to Source Voltage

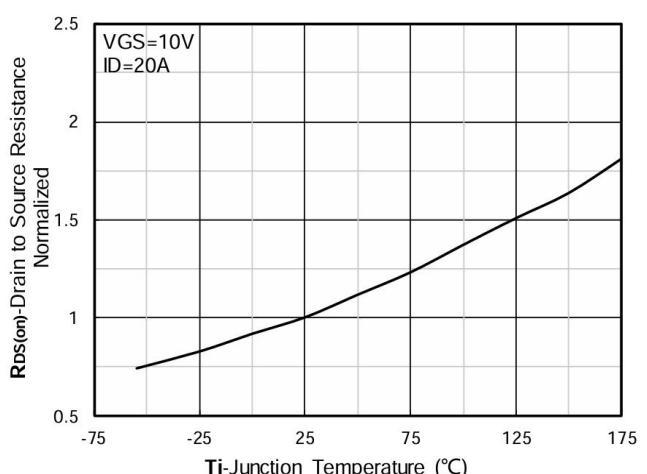


Figure 6. Normalized On-Resistance

### Typical Characteristics

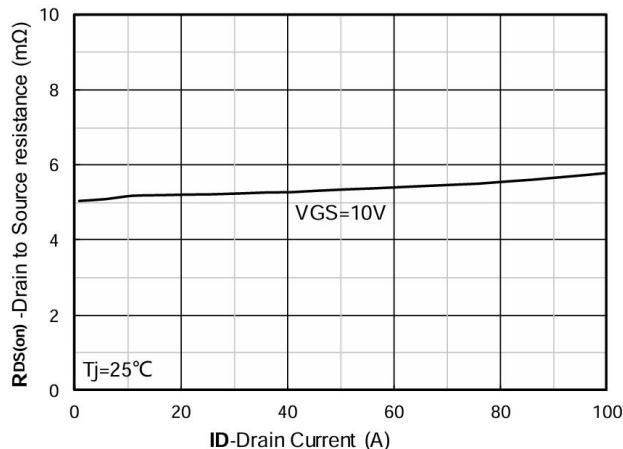


Figure 7.  $R_{DS(on)}$  VS Drain Current

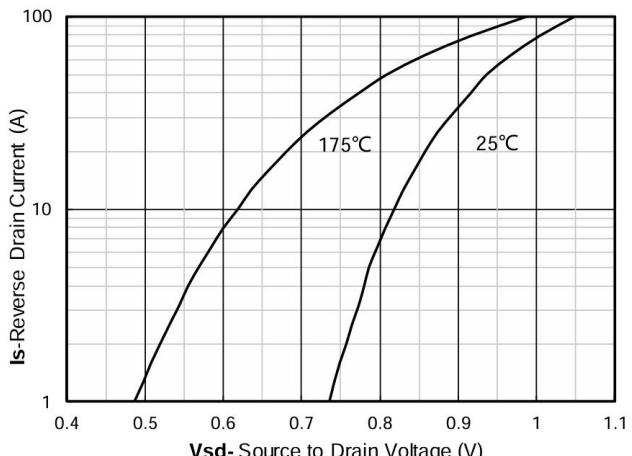


Figure 8. Forward characteristics of reverse diode

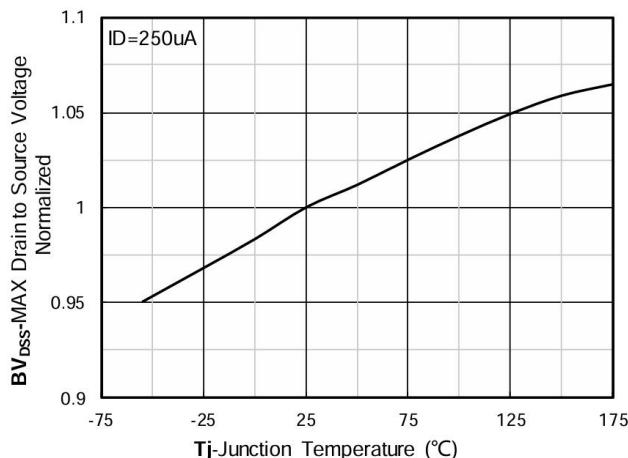


Figure 9. Normalized breakdown voltage

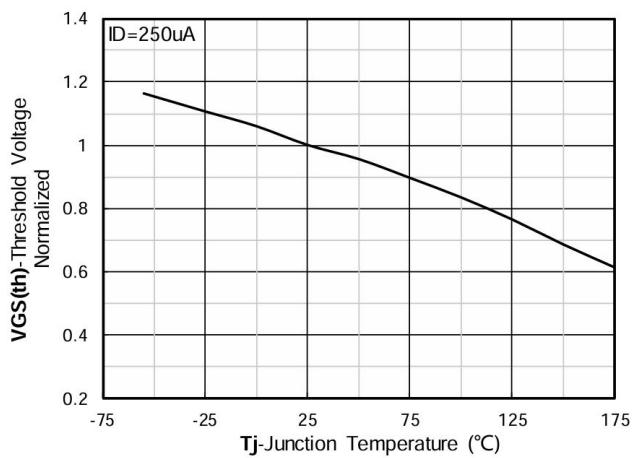


Figure 10. Normalized Threshold voltage

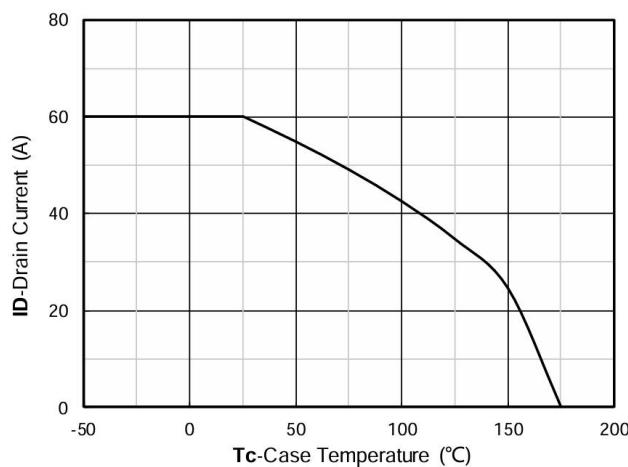


Figure 11. Current dissipation

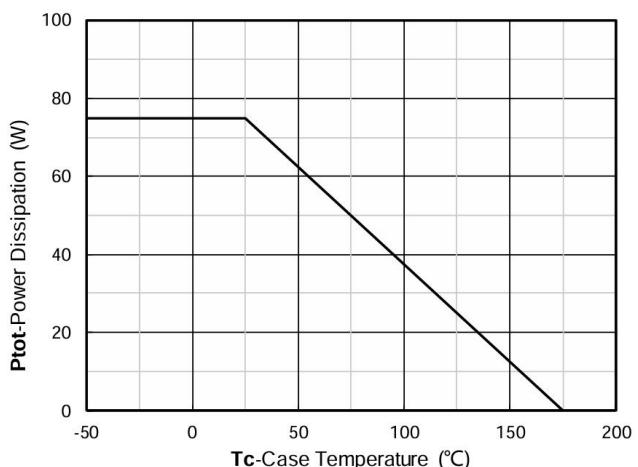


Figure 12. Power dissipation

### Typical Characteristics

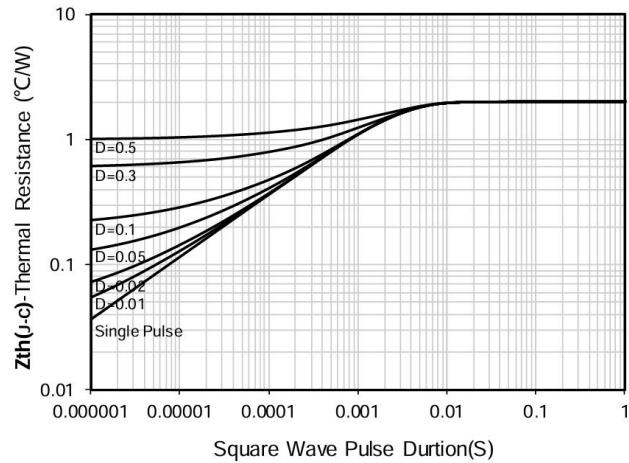


Figure 13. Maximum Transient Thermal Impedance

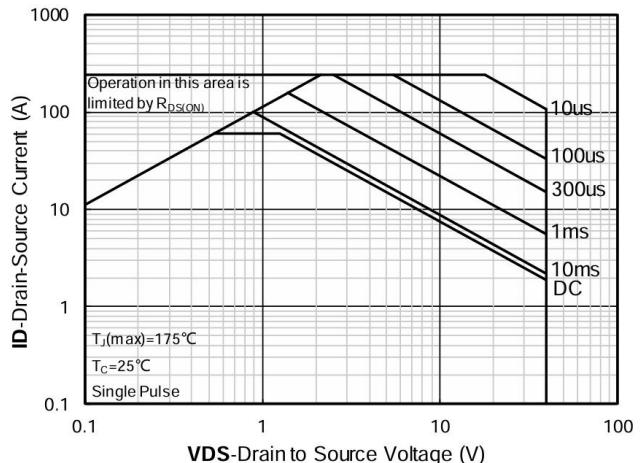
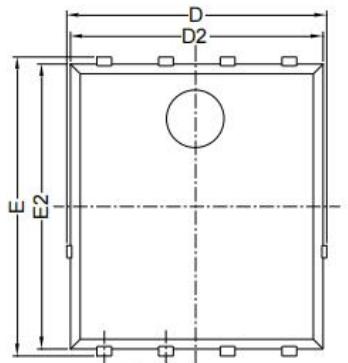
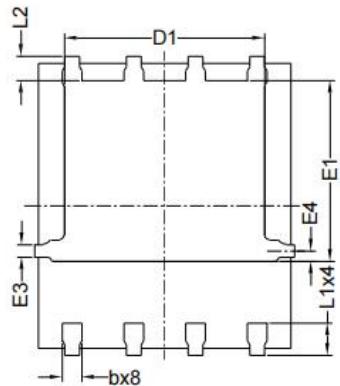
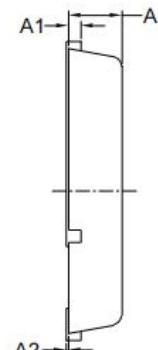


Figure 14. Safe Operation Area

**PDFN5\*6-8L Package Information**

**Top View**  
正面视图

**Bottom View**  
背面视图

**Side View**  
侧面视图

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
D	5.150	5.550	0.203	0.219
E	5.950	6.350	0.234	0.250
A	1.000	1.200	0.039	0.047
A1	0.254 BSC		0.100 BSC	
A2	0.000	0.100	0.000	0.004
D1	3.920	4.320	0.154	0.170
E1	3.520	3.920	0.139	0.154
D2	5.000	5.400	0.197	0.213
E2	5.660	6.060	0.223	0.239
E3	0.254 REF		0.010 REF	
E4	0.210 REF		0.008 REF	
L1	0.560	0.760	0.022	0.030
L2	0.500 BSC		0.015 BSC	
b	0.310	0.510	0.012	0.020
e	1.270 BSC		0.050 BSC	